

# APÉNDICE C

## HOJA TÉCNICA DEL MOSFET DE POTENCIA IRF740

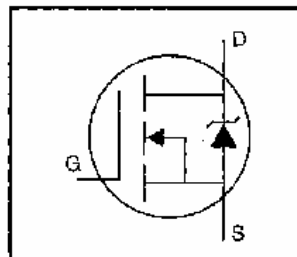
**International Rectifier**

PD-9.375H

# IRF740

HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements



$$V_{DSS} = 400V$$

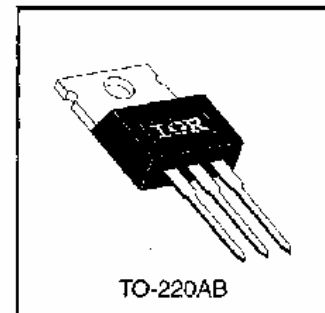
$$R_{DS(on)} = 0.55\Omega$$

$$I_D = 10A$$

### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contributes to its wide acceptance throughout the industry.



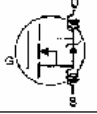
### Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	10	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	6.3	
$I_{DM}$	Pulsed Drain Current ①	40	
$P_D @ T_C = 25^\circ C$	Power Dissipation	125	W
	Linear Derating Factor	1.0	W/°C
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulse Avalanche Energy ②	520	mJ
$I_{AR}$	Avalanche Current ③	10	A
$E_{AR}$	Repetitive Avalanche Energy ④	13	mJ
dv/dt	Peak Diode Recovery dv/dt ⑤	4.0	V/ns
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +150	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf·in (1.1 N·m)	

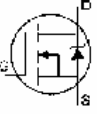
# IRF740



## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	400	—	—	V	$V_{GS}=0V, I_D=250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.49	—	V/°C	Reference to $25^\circ\text{C}$ , $I_D=1mA$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.55	$\Omega$	$V_{GS}=10V, I_D=6.0A$ ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS}=V_{GS}, I_D=250\mu A$
$g_{fs}$	Forward Transconductance	5.8	—	—	S	$V_{DS}=50V, I_D=6.0A$ ④
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	25	$\mu A$	$V_{DS}=400V, V_{GS}=0V$
		—	—	250		$V_{DS}=320V, V_{GS}=0V, T_J=125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS}=20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS}=-20V$
$Q_g$	Total Gate Charge	—	—	63	nC	$I_D=10A$
$Q_{gs}$	Gate-to-Source Charge	—	—	9.0		$V_{DS}=320V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	32		$V_{GS}=10V$ See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	14	—	ns	$V_{DD}=200V$
$t_r$	Rise Time	—	27	—		$I_D=10A$
$t_{d(off)}$	Turn-Off Delay Time	—	50	—		$R_G=9.1\Omega$
$t_f$	Fall Time	—	24	—		$R_D=20\Omega$ See Figure 10 ④
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	1400	—	pF	$V_{GS}=0V$
$C_{oss}$	Output Capacitance	—	330	—		$V_{DS}=25V$
$C_{riss}$	Reverse Transfer Capacitance	—	120	—		$f=1.0MHz$ See Figure 5

## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	10	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	40		
$V_{SD}$	Diode Forward Voltage	—	—	2.0	V	$T_J=25^\circ\text{C}, I_S=10A, V_{GS}=0V$ ④
$t_{rr}$	Reverse Recovery Time	—	370	790	ns	$T_J=25^\circ\text{C}, I_F=10A$
$Q_{rr}$	Reverse Recovery Charge	—	3.8	8.2	$\mu C$	$di/dt=100A/\mu s$ ④
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )				

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ②  $V_{DD}=50V$ , starting  $T_J=25^\circ\text{C}$ ,  $L=9.1mH$ ,  $R_G=25\Omega$ ,  $I_{AS}=10A$  (See Figure 12)
- ③  $I_{SD}\leq 10A$ ,  $di/dt\leq 120A/\mu s$ ,  $V_{DD}\leq V_{(BR)DSS}$ ,  $T_J\leq 150^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .